

Electron Microscopy

- 1930s (Ruska & Knoll)
 - 75 keV e- LINAC
 - Higher resolution than light microscopy



Physics:
MCMLXXXVI

- What's happened since then?
- Where Accelerator R&D could help advance the state-of-the-art

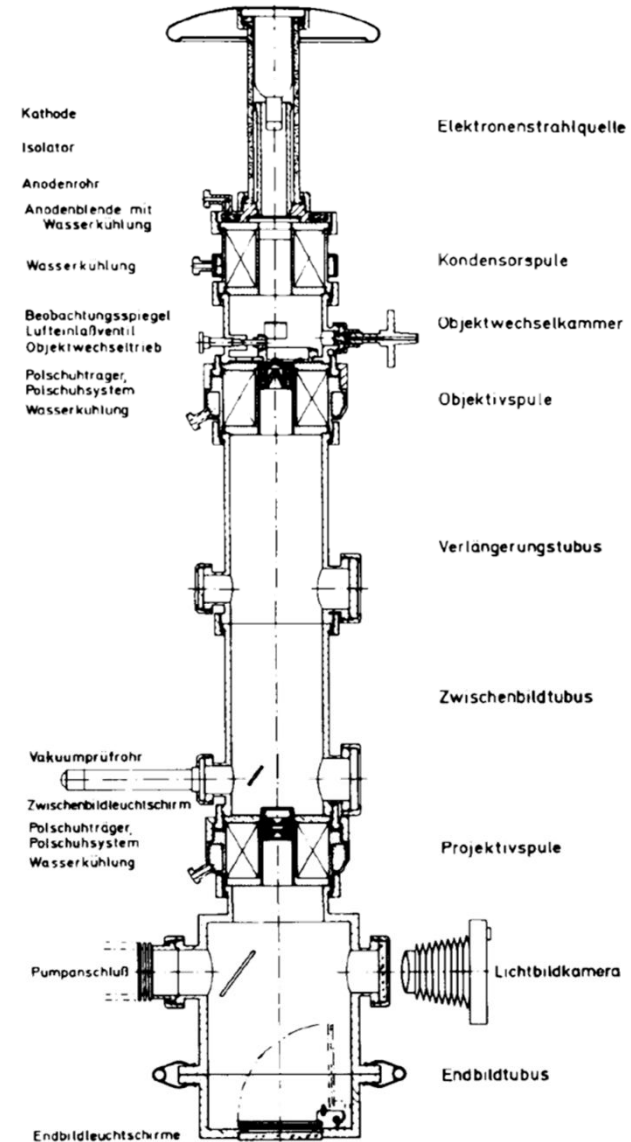


Fig. 5: First (two-stage) electron microscope magnifying higher than the light microscope. Cross-section of the microscope column (Re-drawn 1976) [15].

Synergies

- Describe potential synergies and connections to other GARD thrusts and other SC offices (BES, NP, QIS, FES, etc)

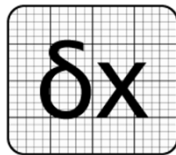
There are many types of 'electron microscopes'

Concentrate here on those with beam energies sufficient for atomic resolution
And on real space imaging (diffraction – generally – averages over sample)

Connections: EM is a key discovery tool for materials science and structural biology

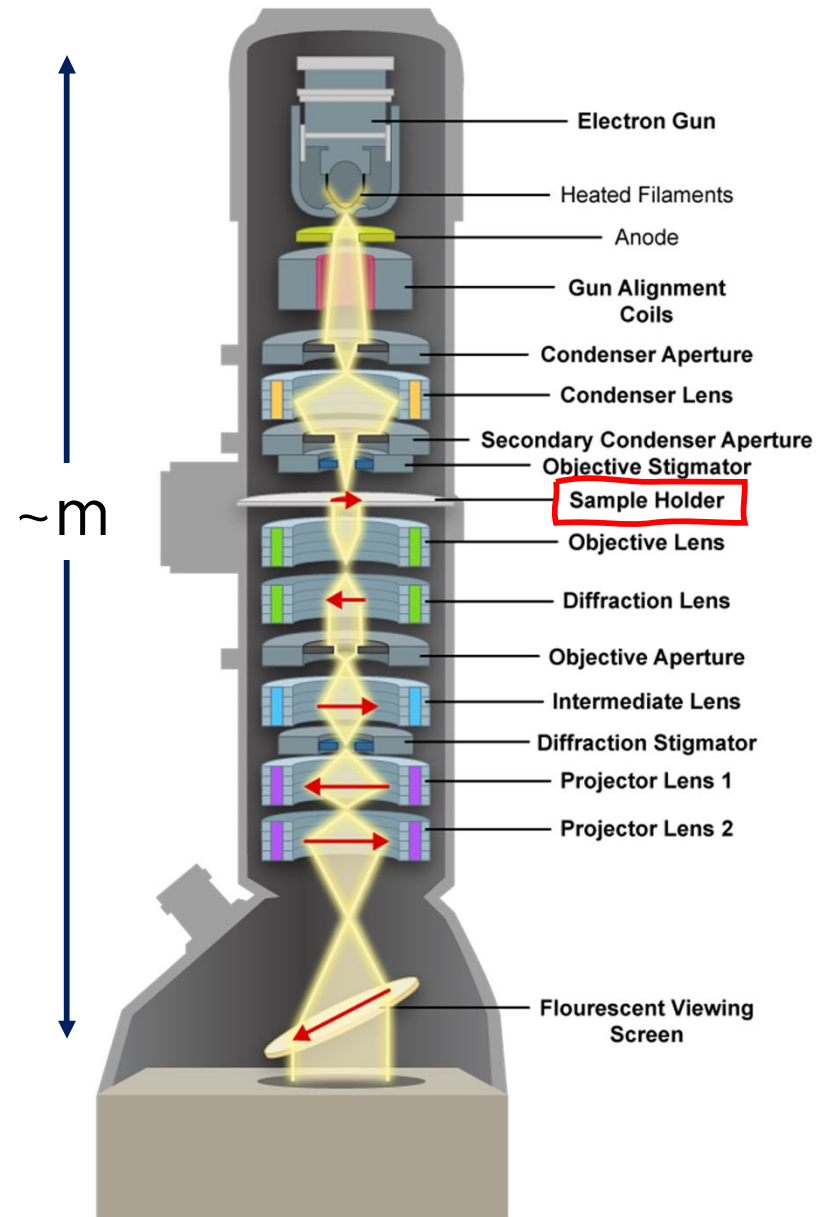
- Motivation (why EM?)

- Challenges

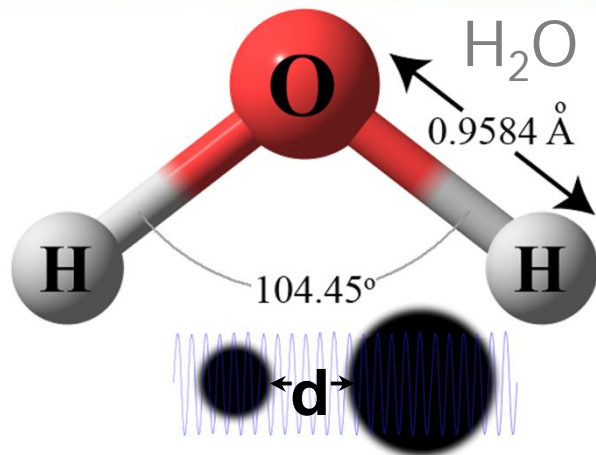


Conventional TEM

- $E \sim 10^5 \text{ eV}$
- $I \lesssim \text{nA}$
 - $\rightarrow 1 \text{ e}^-$ in column at a time
 - \rightarrow ~~space charge~~
- At 300 keV
 - $\lambda \sim 0.02 \text{ \AA}$
 - $\beta \sim 0.8$

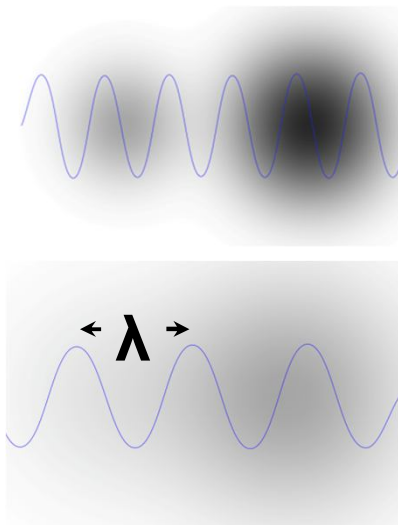


Seeing Atoms



Resolve atoms – spaced $d \sim 1 \text{ \AA}$ apart

Diffraction Limit: $\lambda < d$

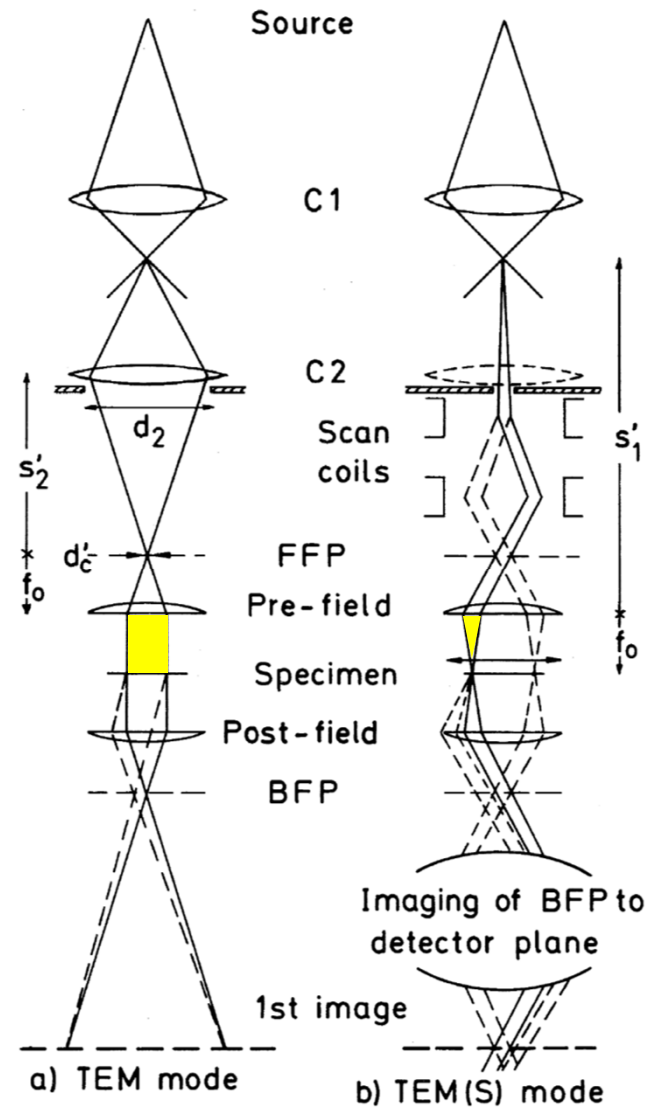


Microscope	λ [Å]
Visible light	4,000
Soft X-ray	≤ 10
Hard X-ray	≤ 1
Electron	$\ll 0.1$

Electron Microscopy continues to be the best way to image at the atomic (or near-atomic) scale

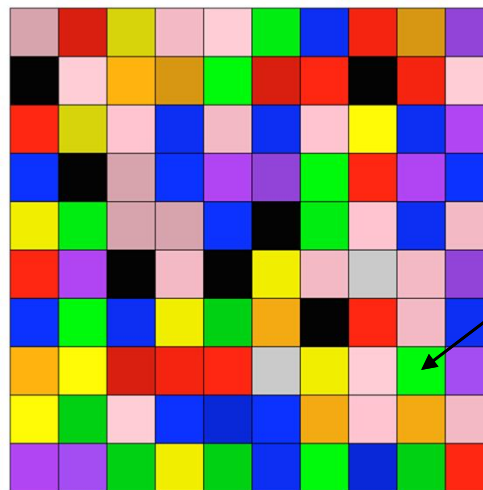
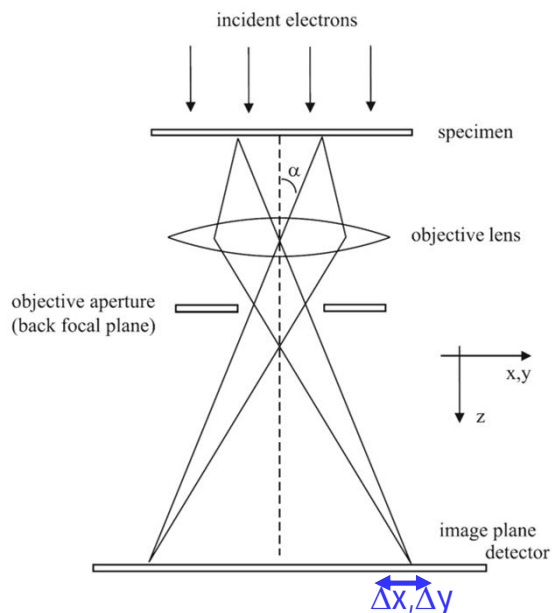
(S)TEM – “equivalent”

TEM: parallel beam on sample

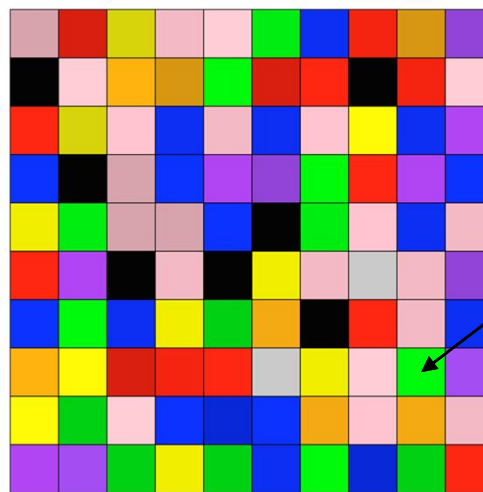
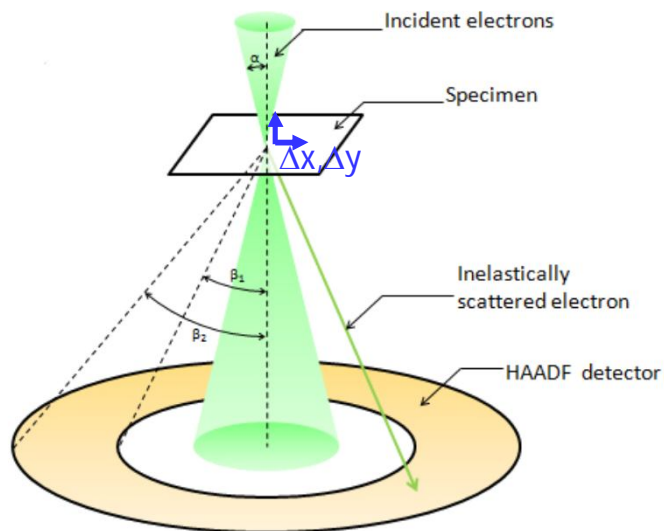


STEM: point-like beam on sample

(S)TEM

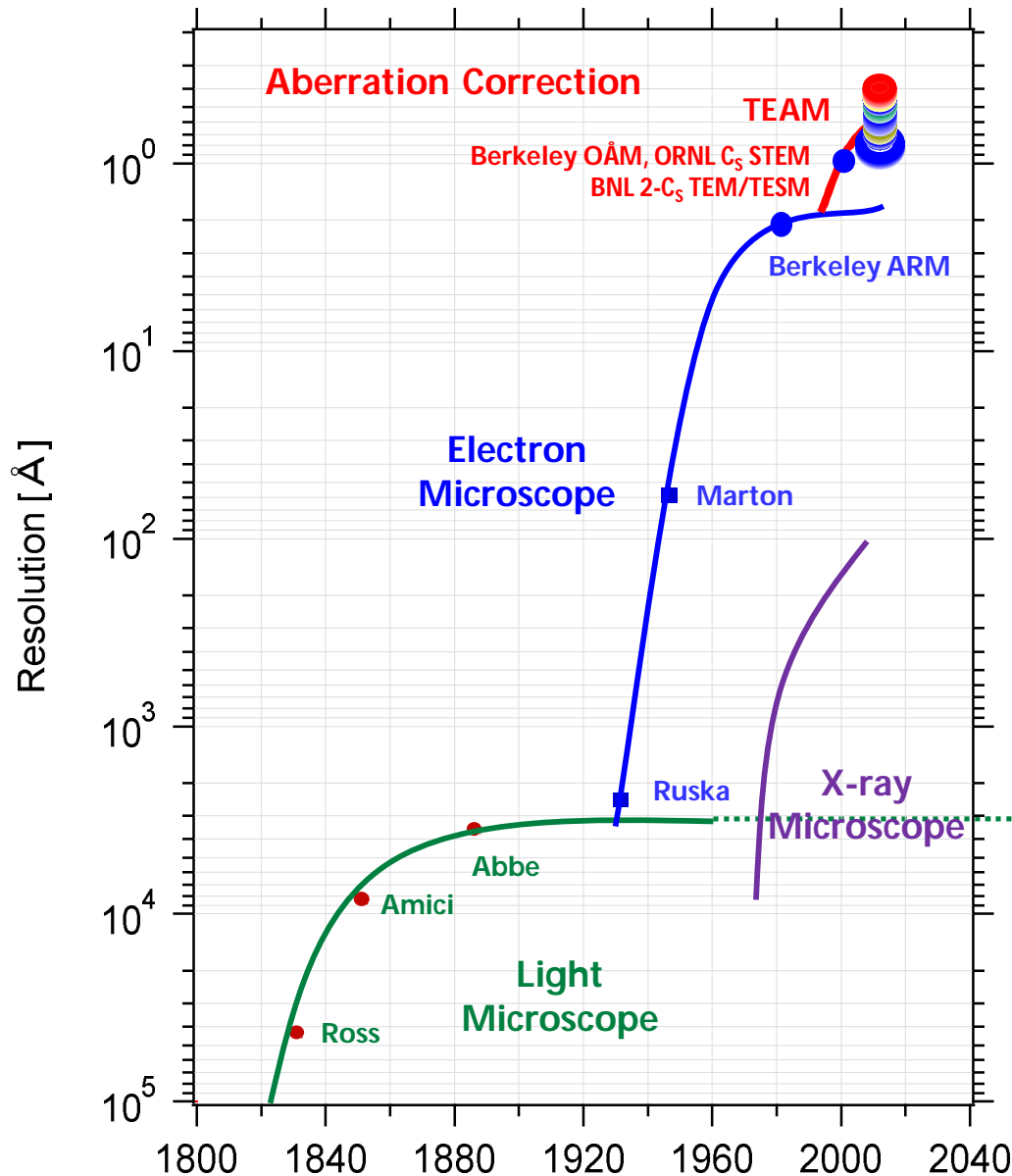
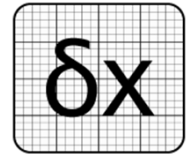


$$\left(\sum_{\Delta x, \Delta y} e^- \right) \times factors$$



$$\left(\sum_{\Delta x, \Delta y} e^- \right) \times factors$$

Optics



Aberration correction

Technology gets better

- Better power supplies
- Improved designs
- ...

Computers

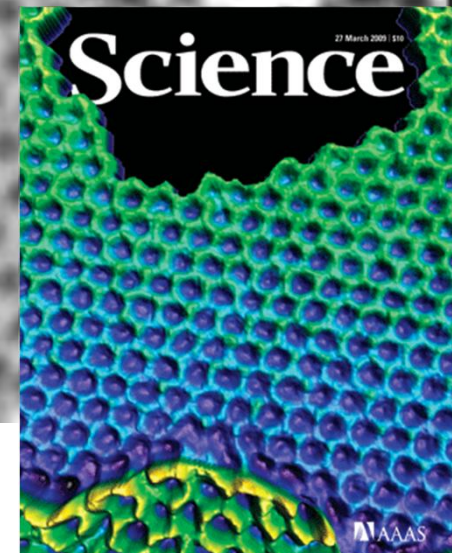
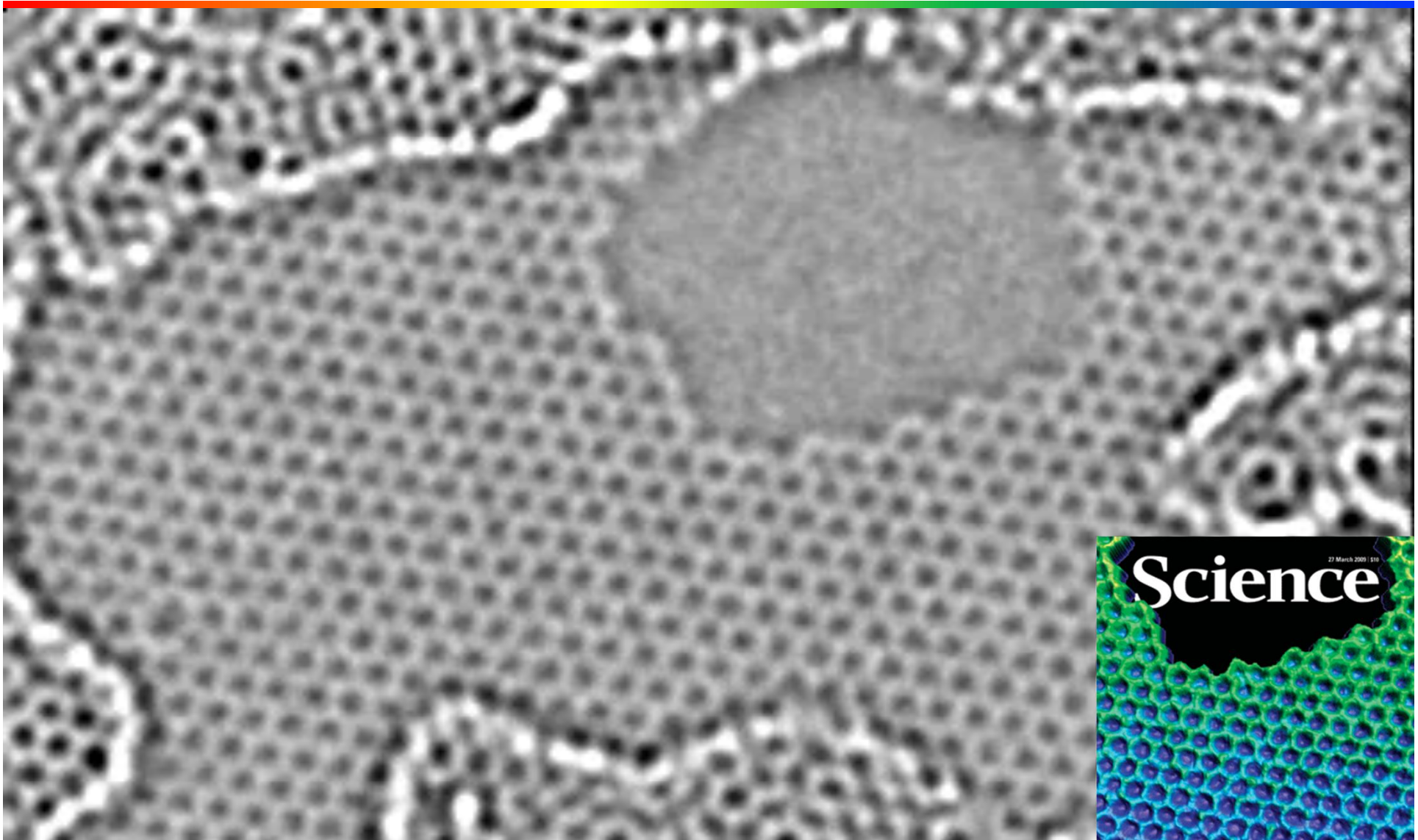
Light microscopy at the diffraction limit
Can sometimes be improved by *super-resolution*



Chemistry:
MMXIV

EM: After Rose
X-ray: Kirz and Jacobsen XRM2008

Graphene on TEAM 0.5

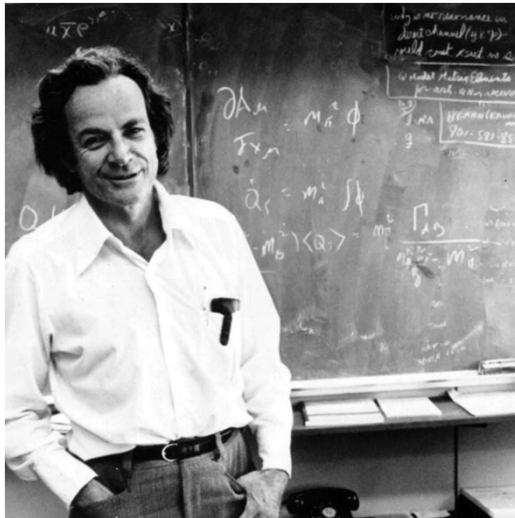


Graphene at the Edge: Stability and Dynamics *Science* 27 Mar 2009 : 1705-1708

Challenge



*"It would be very easy to make an analysis of any complicated chemical substance; all one would have to do would be to look at it and see where the atoms are. The only trouble is that the electron microscope is one hundred times too poor ... I put this out as a challenge: **Is there no way to make the electron microscope more powerful?"***

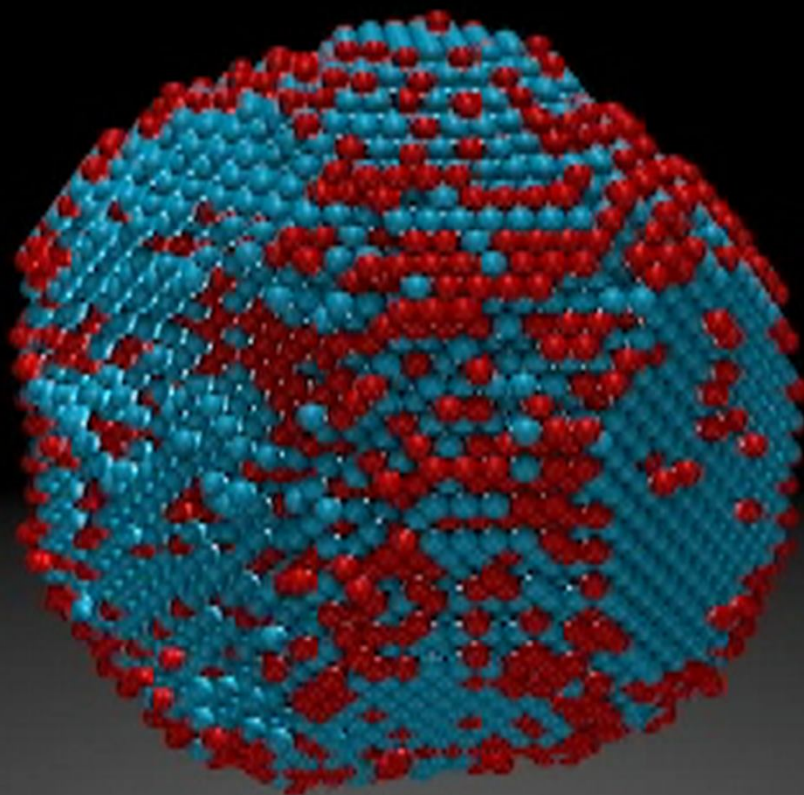


– Richard P. Feynman, 1959,
"There's Plenty of Room at the
Bottom"

Getting There



Y Yang, CC Chen, MC Scott*, C Ophus*,..., P Ercius, et al., Nature 542, 75 (2017) Movie from F Niekiel and C Ophus

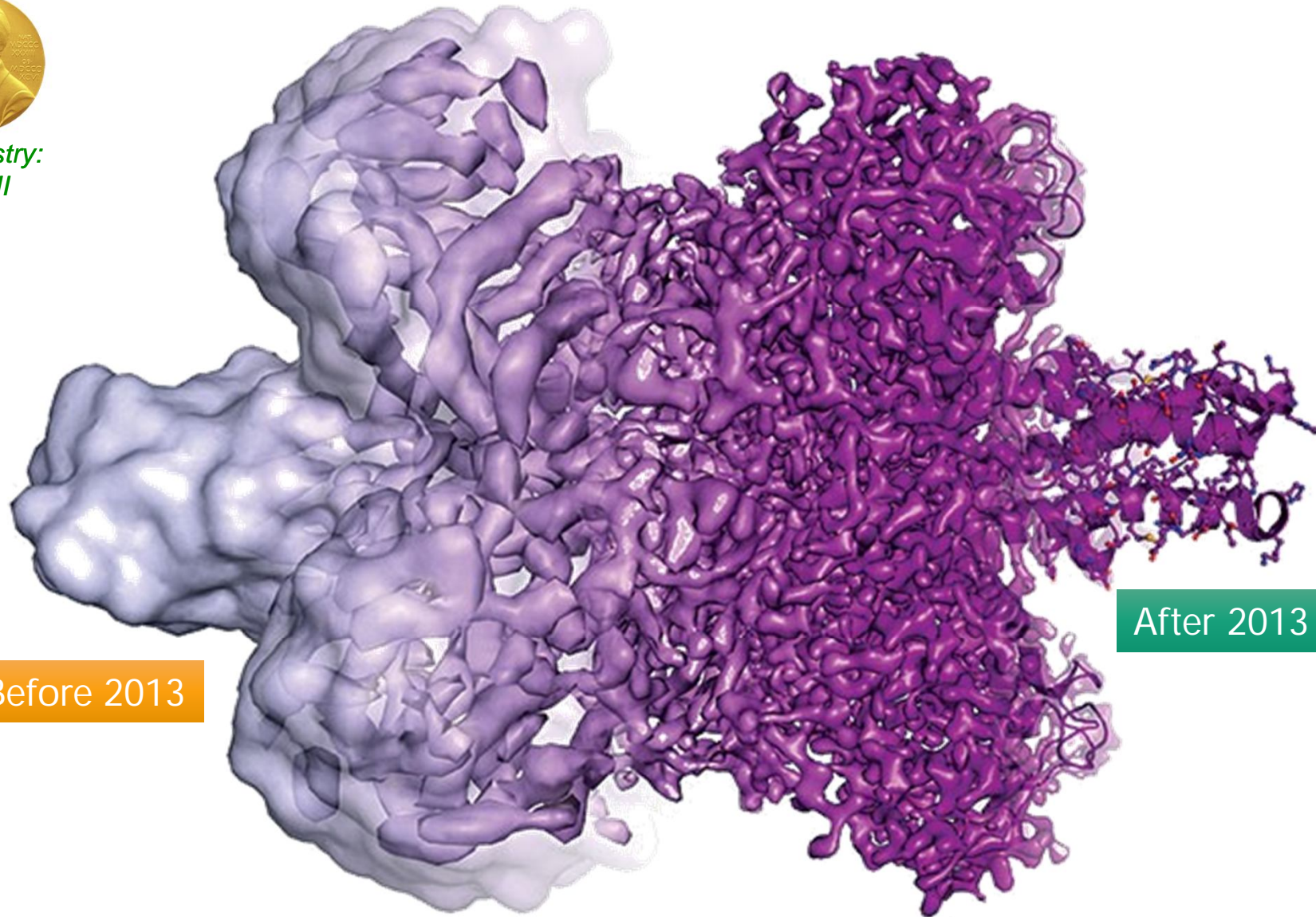


We can now see – and identify – every atom in a nanoparticle

cryoEM



Chemistry:
MMXVII



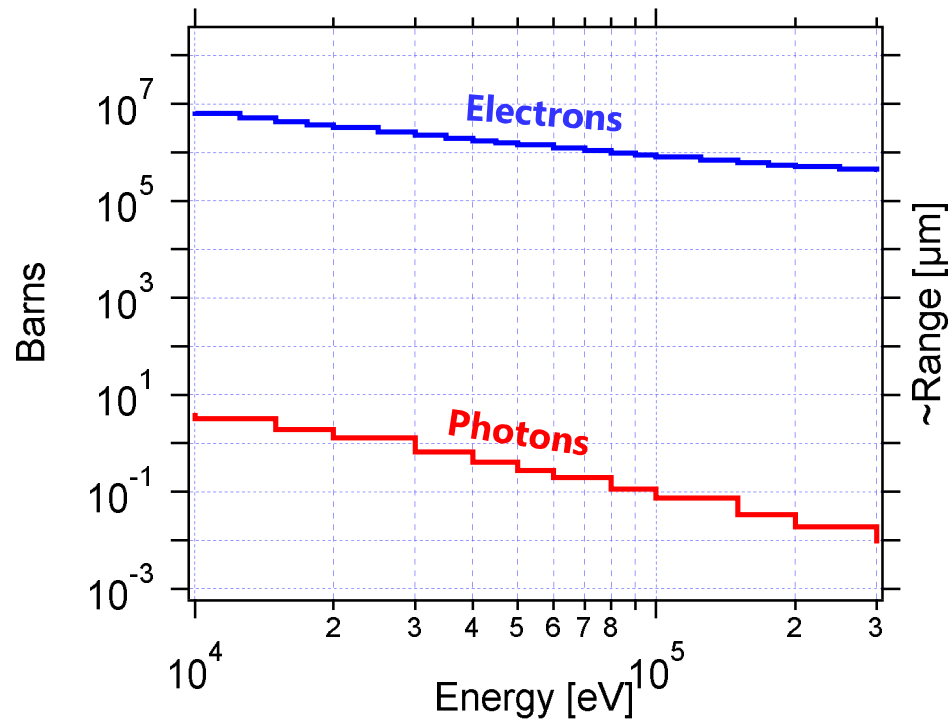
Before 2013

After 2013

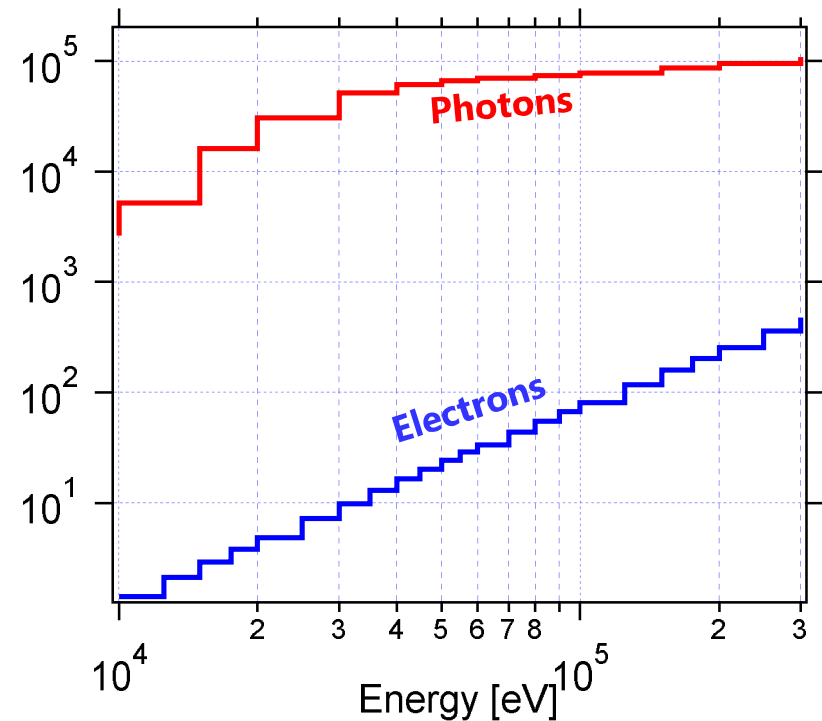
Electrons vs. X-rays



Elastic Cross Section



Range



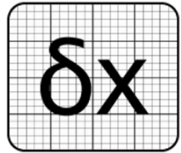
Carbon, here, as an example

Introduction: Grand challenges

For Electron Microscopy

- **Grand challenge #1 (beam intensity):** How do we increase beam intensities by orders of magnitude?
- **Grand challenge #2 (beam quality):** How do we increase beam phase-space density by orders of magnitude, towards quantum degeneracy limit?
- **Grand challenge #3 (beam control):** How do we control the beam distribution down to the level of individual particles?
- **Grand Challenge #4 (beam prediction):** How do we develop predictive “virtual particle accelerators”?

Challenges



Spatial Resolution – largely solved
See atoms (under ideal observation conditions)



Energy Resolution – source and optics
 $\delta E \rightarrow 0$: Spectroscopy++



Temporal Resolution – source+
 $\delta t \rightarrow 0$: What are the limits?

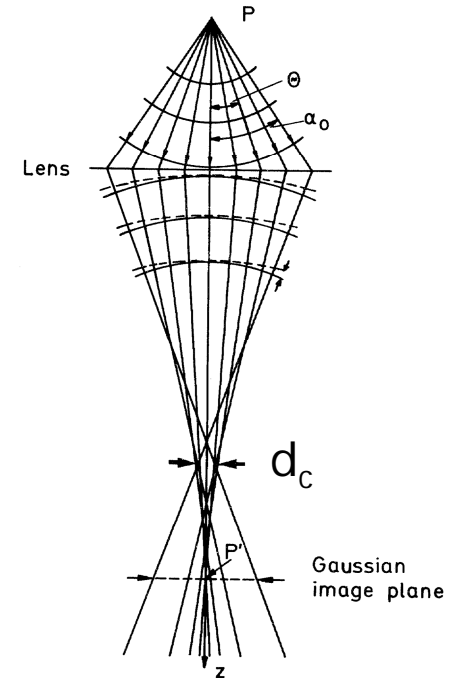
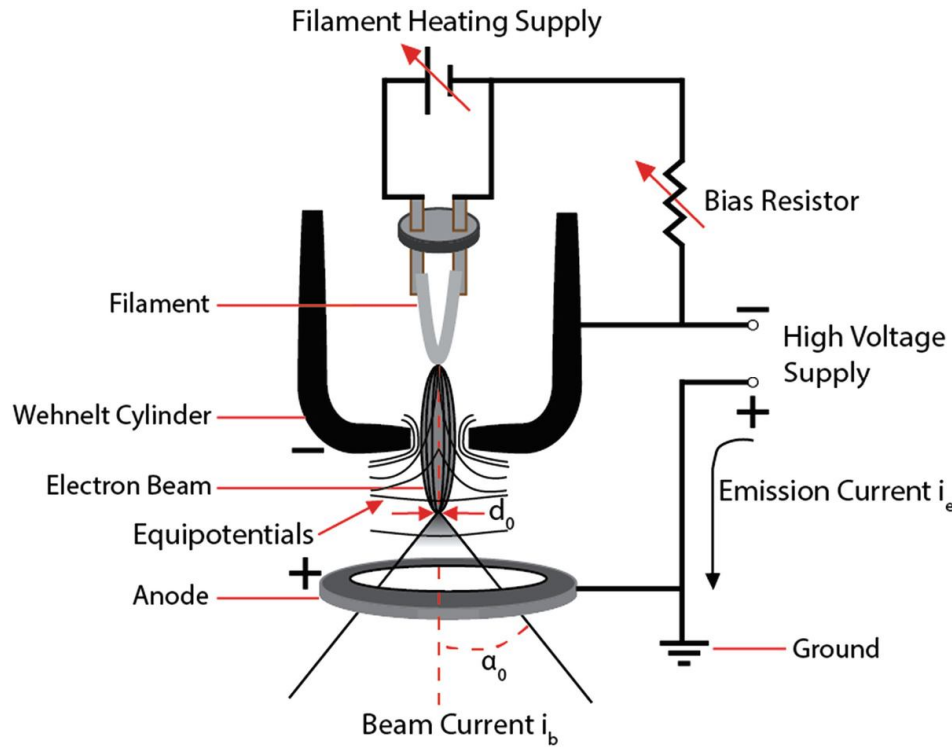
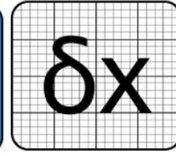


“Efficiency” – reduce sample damage
More buck for the bang



Temperatures other than room temperature
Atomic resolution at $T \sim 0$ (quantum phenomena)

The Source



Brightness: $\beta = \frac{I}{(\pi d_0 \alpha_0)^2}$

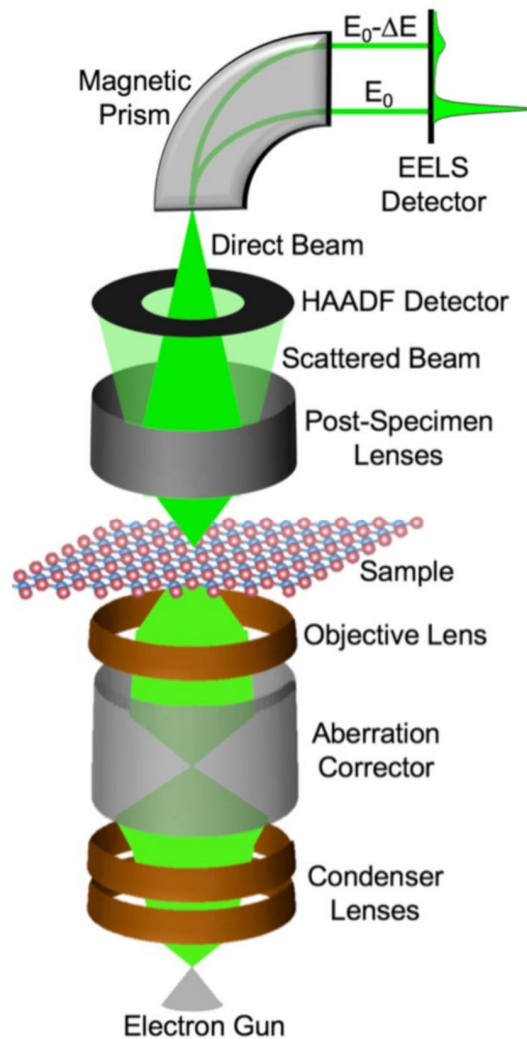
Source	β [A/m ² Sr]
Thermionic	10 ⁹
Schottky FEG	5x10 ¹⁰
Cold FEG	10 ¹³

Energy Spread:

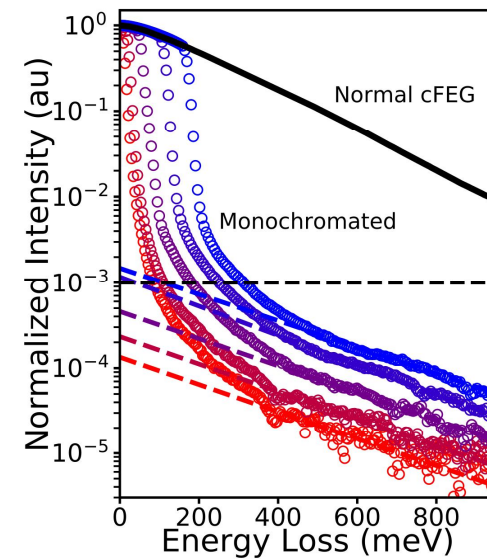
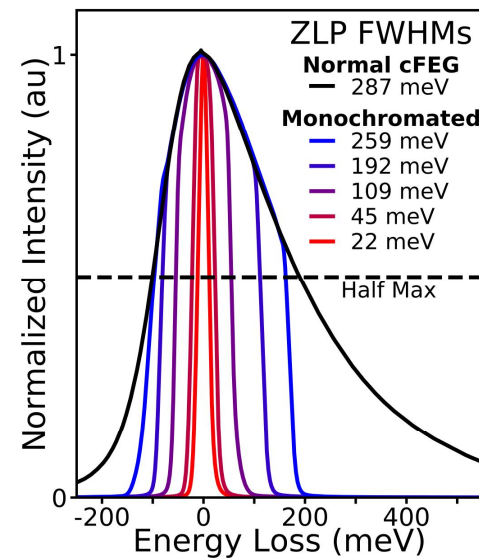
$$d_c = \frac{1}{2} C_c \frac{\Delta E}{E} \frac{1 + E/E_0}{1 + 2E/E_0} \alpha_0 M$$

$$\rightarrow \frac{\Delta E}{E} \sim 10^{-6}$$

Spectroscopy



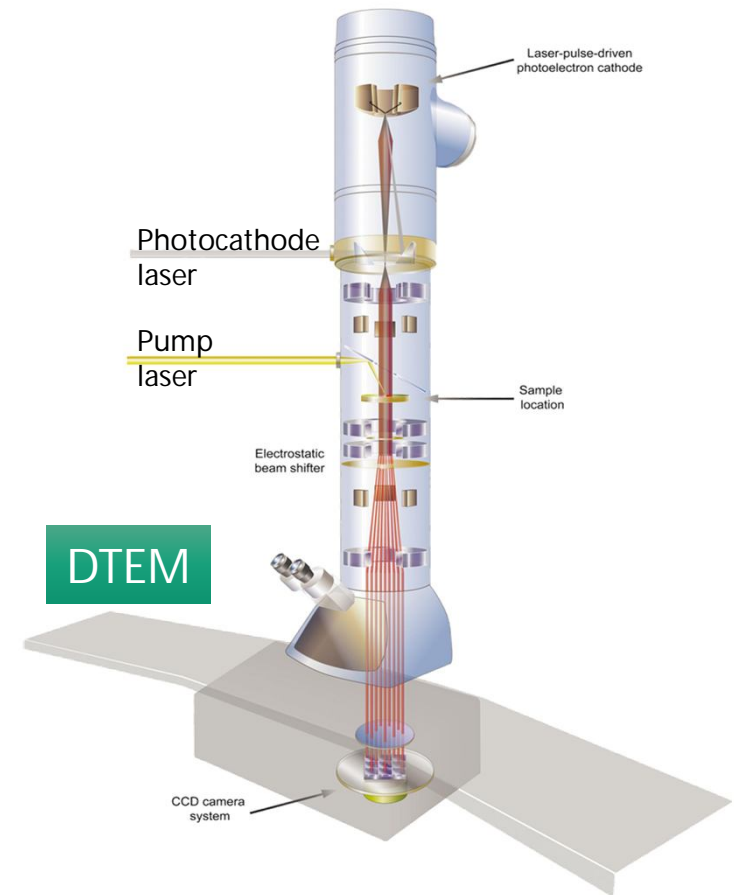
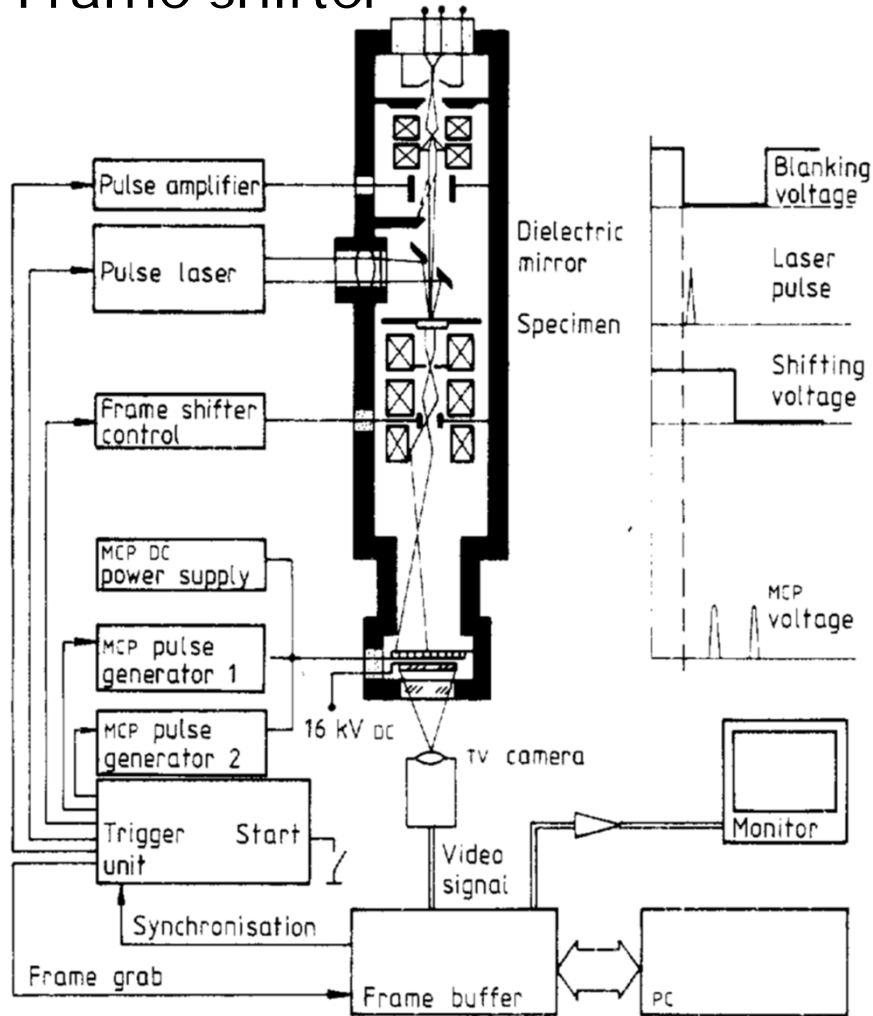
- Inelastic scattering
- STEM
- (Today) beam monochromated to reduce ΔE
 - Reduction in beam current



Time Resolved [ns]

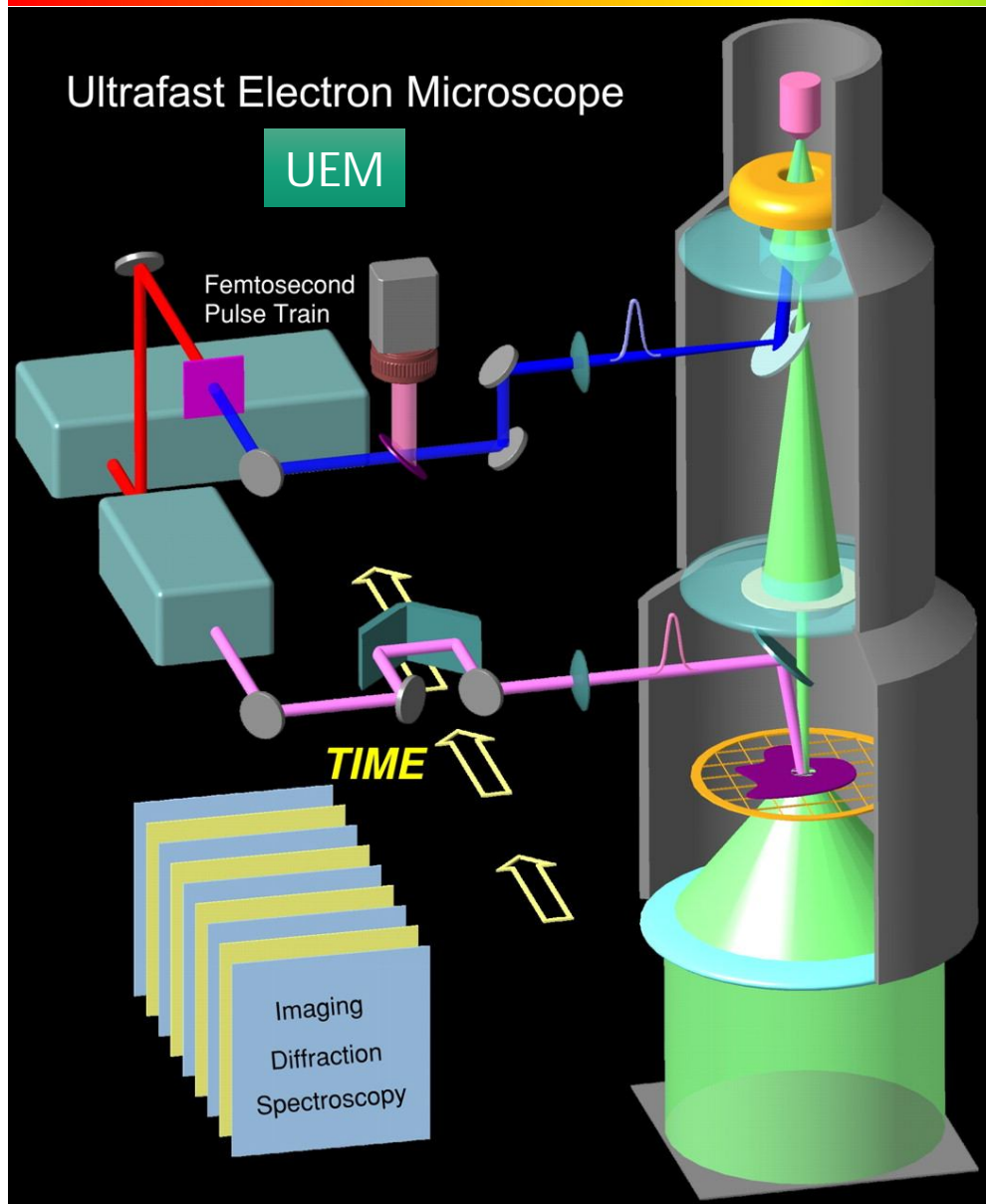


- Laser-driven photocathode
- Frame shifter



Bostanjoglo, *Ultramicroscopy* 1987
Bostanjoglo *J. Phys. E: Sci. Instrum.* 1989

Time Resolved [$<ps$]

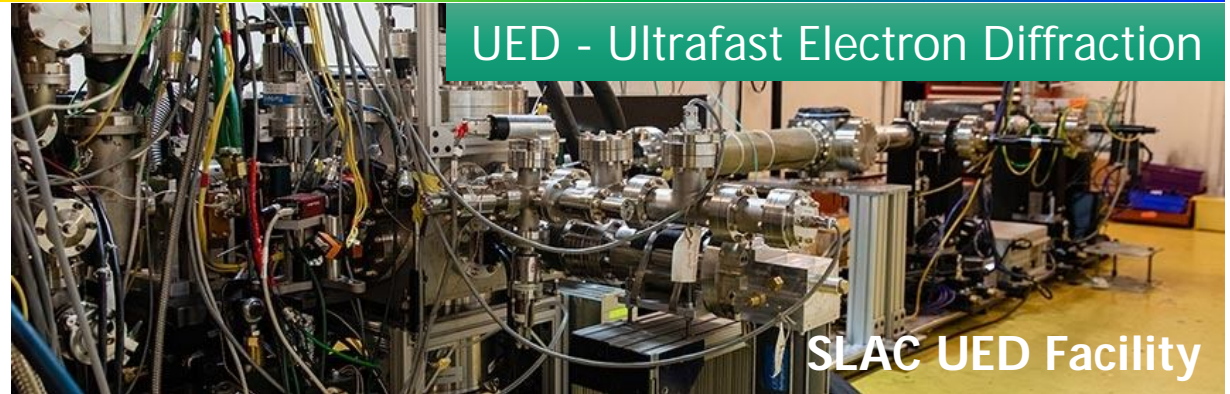


- DTEM
 - Pump
 - Probe-Probe-Probe
 - Many e- / Probe pulse
- UEM
 - Pump
 - Probe
 - ~1 e- / Probe pulse

Time Resolved [$<ps$]



- FEL gun
- Bunch charge Q
- Bunch width δt
- $E \sim \text{MeV}$ (space charge)



SLAC UED Facility	
Parameter	Value
Electron beam energy	2 - 4 MeV
Repetition rate	Single shot \rightarrow 360 Hz
Charge per pulse	1 - 100
Bunch length	<150 fs FWHM*
Beam spot size	100-200 μm (typical), 10 μm (FWHM) focused

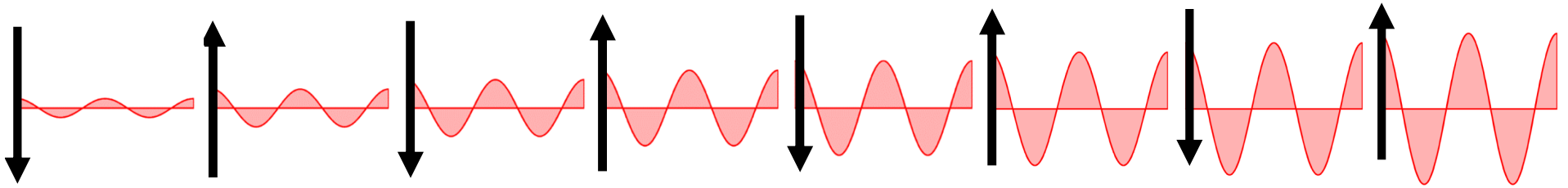
LBNL Hires
730 keV
≤ 1 MHz
0.1 - 10 fC
~ 100 fs FWHM*
50-200 μm (typical)

*(depending on charge)

Multipass (“Quantum”) EM



Consider a weak phase signal:  $\uparrow \phi_0$ max phase shift



Do 1 pass m times. *Intensity* $\propto m\phi_0^2$

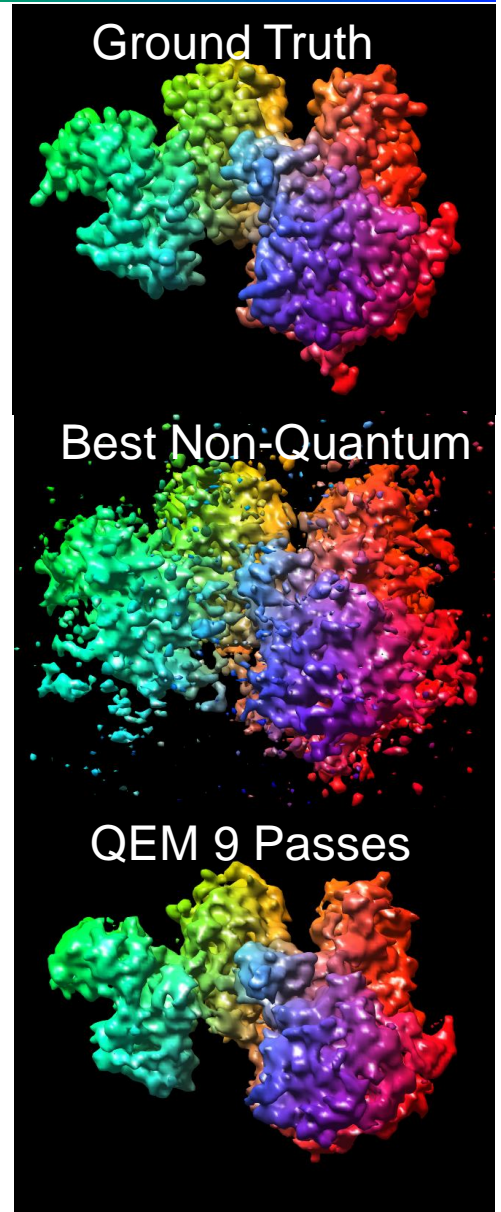
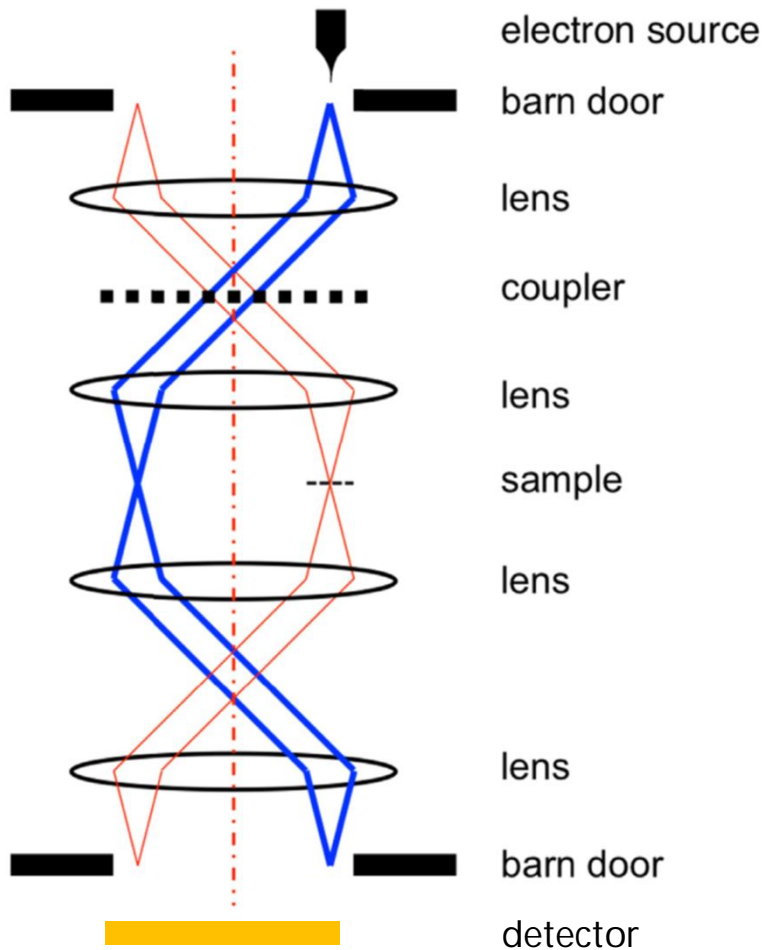
Do m passes 1 time. *Intensity* $\propto m^2\phi_0^2$

In each case, the sample sees m electrons. “Figure of merit”:

Intensity/Dose $\propto \phi_0^2$ – single pass

Intensity/Dose $\propto m\phi_0^2$ – single pass

Multipass ("Quantum") EM



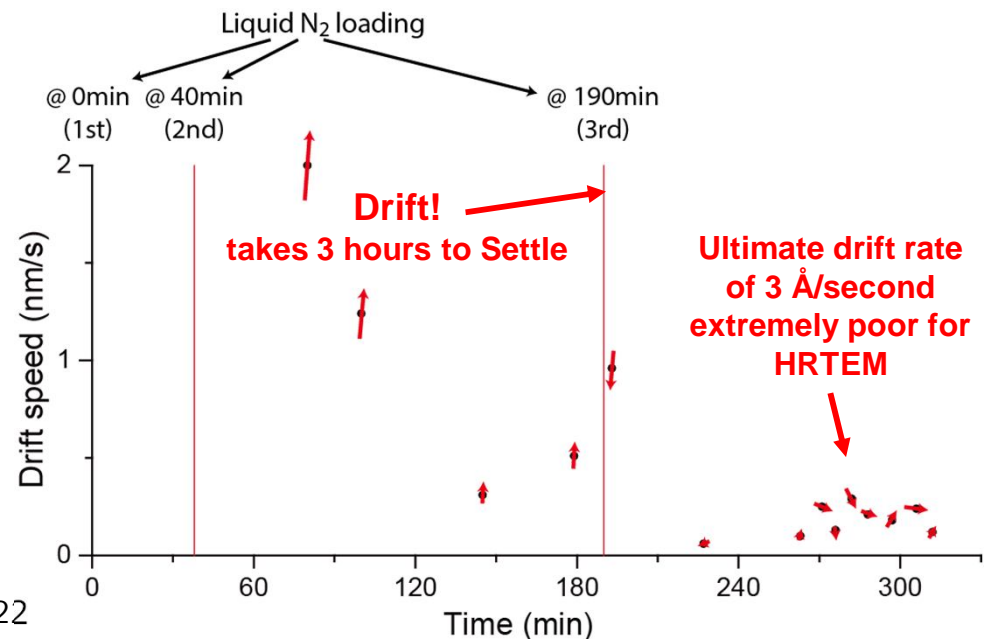
Temperature and Stability



Atomic resolution at (very low temperatures)

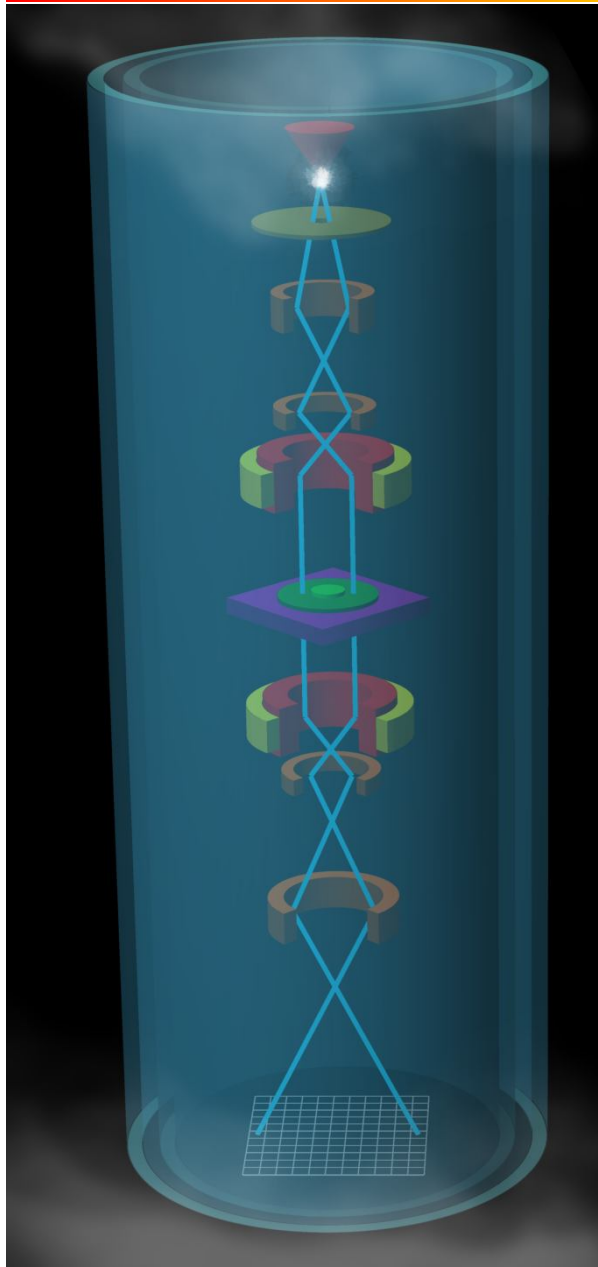
- Electron-Lattice Coupling
 - exploration of novel phases in temperature regimes not currently possible at atomic resolution
- Single photon quantum emitters / optical coupling / QIS
 - spectroscopy at low temperature - similar to STM, but for bulk samples.
- In-situ studies
 - stability → multimodal atomic characterization of both hard and soft materials

Drift on TEAM-I at 77K



Drift data from TEAM I - W.C. Lee, J. Ciston, P. E. Ercius, et al.
Similar to CryoTEM results from other facilities
(i.e. - L. Kourkoutis @ Cornell and Y. Zhu @ BNL)

All-Superconducting TEM



- Conceptual R&D at LBNL
- $\frac{\Delta I}{I}$ – SC persistent currents
- $\frac{\Delta x}{x}$ – CTE $\rightarrow 0$ at $T \rightarrow 0$

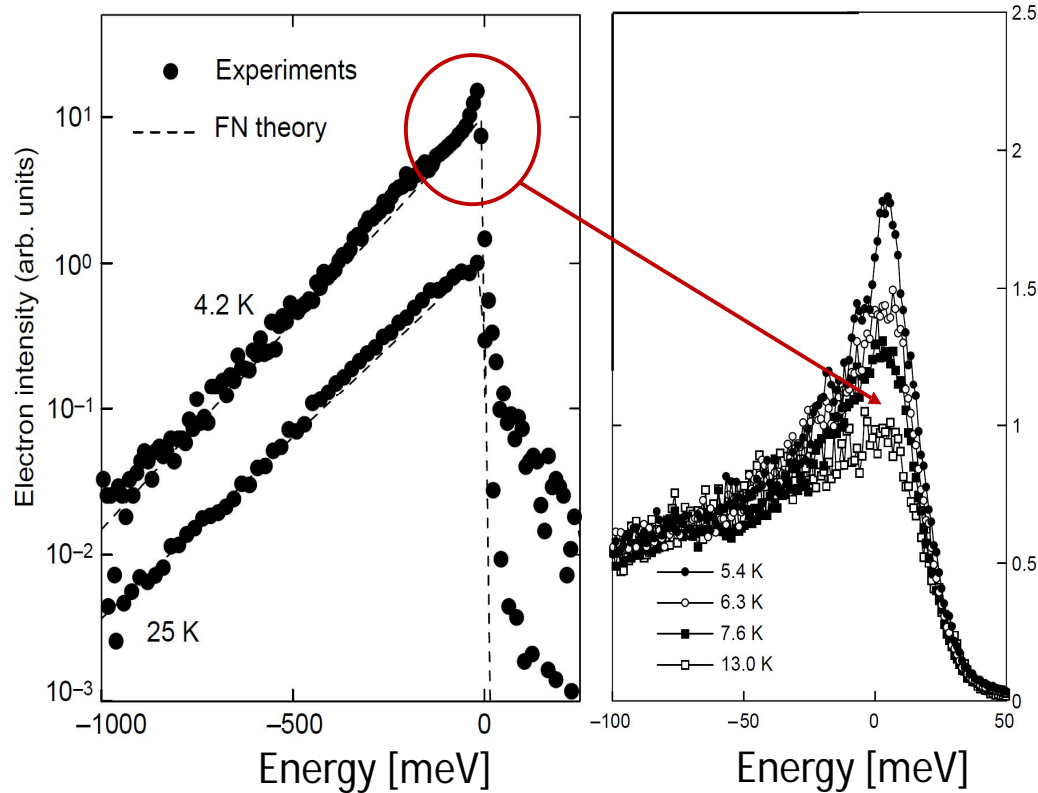
Continental drift $\sim 1 \text{ \AA} / 0.1 \text{ s}$



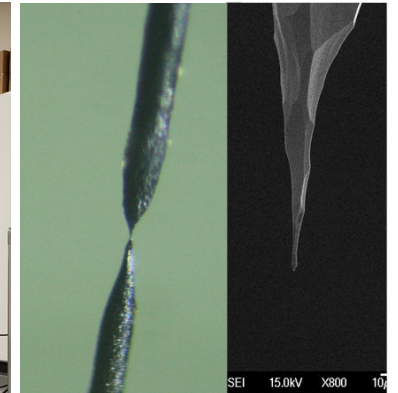
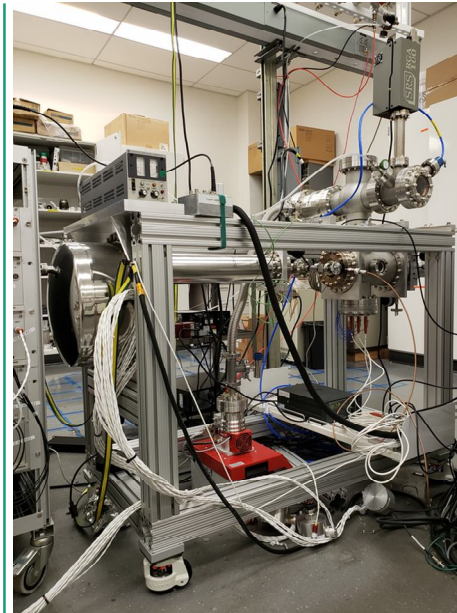
Superconducting Field Emitters



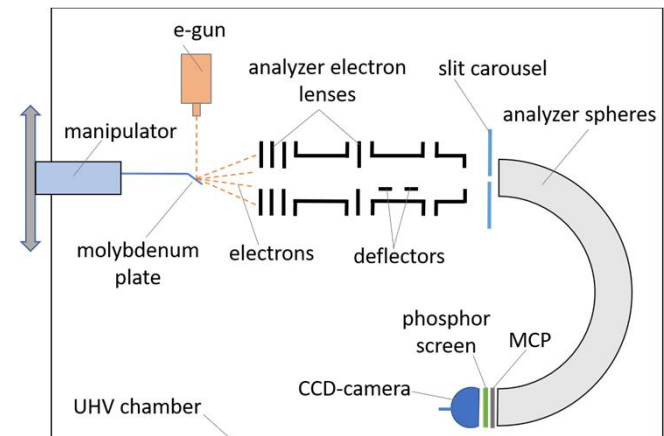
Field emission from superconducting Ni tip (<9.2 K)



- 10-fold increase in intensity
- 10-fold smaller energy distribution (20 meV)



Tip fab: $r \sim 10$ nm



Ni tip test UHV setup at the Molecular Foundry

K. Nagaoka et al, Nature 1998
K. Yuasa et al, Phys. Rev. B 2009

Challenges



● DTEM – **many e-/bunch** $\delta t \sim ns$ $\delta x \sim nm$

- Resolution limits

- “Slow”: Speed of sound ~ 1 Atom / 100 fs

● UED – **many e-/bunch** $\delta t \sim f/ps$ $\delta x \sim \mu m$

- Resolution limits

- *Diffraction* (not imaging)

● UEM – **1 e-/bunch** $\delta t \sim f/ps$ $\delta x \sim \text{\AA}$

- Pump-Probe

- Many shots needed

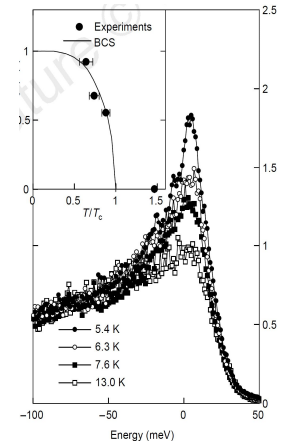
- Sample needs Δt to relax before next shot

● Can we have it all?

Challenges



- Can we get a high-brightness source (?) with
 - $\delta E \sim 0$ – improves every aspect of microscopy
 - Especially spectroscopy
 - “Controllable” δt (with $\delta E \sim 0$)
 - At what current?
- Can we increase the beam current?
 - While preserving all other properties
 - XFELs \rightarrow MHz
 - EM imaging: ~ 100 fC / shot

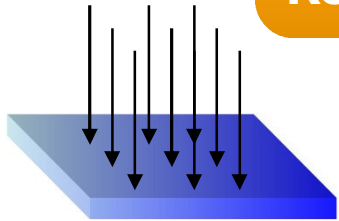


Challenges



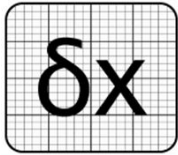
- How does EM “outrun” damage?

Poisson statistics: $\Delta N = \sqrt{N}$
Contrast $C \propto \Delta N/N$
Rose Criterion: $C \geq k$ ($k = 5$)



$N = f \times D \times d^2$
 $D = \text{Dose} = \text{ptcl/s/Area} \times \text{Time}$
 $f = \text{factor for scattering and detection efficiency}$
 $\rightarrow D \sim k^2/f \times C^2 \times d^2$
But $C \sim d \rightarrow \mathbf{D \sim 1/f \times d^4}$

- **Factor 2 in resolution = 16 x Dose**
- Can we employ “entanglement”?
 - $\frac{1}{\sqrt{N}} \rightarrow \frac{1}{N}$
- How to realize?



● The electron microscope is a

- Low energy
- Low current
- Quasi-relativistic

linear accelerator

● But remarkably successful



● Fertile common ground to explore

- *The ABP thrust explores and develops the science of accelerators and beams to make future accelerators better, cheaper, safer, and more reliable. Particle accelerators can be used to better understand our universe and to aid in solving societal challenges.*